Application/Control No. Applicant(s)/Patent Under Reexamination 10/604,599 HO ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Po-Wei (Dennis) Chen 2676 **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-6,774,953 B2 08-2004 Champion et al. 348/651 Α Lee, Jae Min US-6,654,026 B2 11-2003 345/600 В US-6,621,497 B1 09-2003 Sugiura et al. C 345/600 US-5,596,510 A 01-1997 Boenke, Mark 358/523 D US-Ε US-F US-G US-Н US-US-J US-K US-US-M FOREIGN PATENT DOCUMENTS **Document Number** Date * Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Q R

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